Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/539,223	LEE ET AL.		
Examiner	Art Unit		

SEARCHED							
Class	Subclass	Date	Examiner				
757	40	6/06	Swc				
257	40	12/06	SWC				
	762	,					
	759						
251	752	12106	SwC				
	753	·					
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class	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
EAST see printout	12/06	SWC			
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